	CN NO	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/726,363	LEETE ET AL.
Examiner	Art Unit
Chun-Kuan (Mike) Lee	2181

SEARCHED			
Class	Subclass	Date	Examiner
710	22	4/21/2006	CHUN- KUAN Lee
710	48	4/21/2006	
710	62-64	4/21/2006	
710	107	4/21/2006	
710	117	4/21/2006	
710	260	4/21/2006	V

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOT (INCLUDING SEARCH		')
	DATE	EXMR
(EAST) US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB Google Inventor search on PALM and EAST	4/21/2006	CHUN- KUAN Lee